



# Status of Silicon Tracker digitization and hit reconstruction in MarlinReco<sup>1</sup>

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# Contents

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1. What we had till now
2. Class *SiTrkDigiProcessor*
3. Class *GeomTiling*
4. Class *DetUnit*
5. Class *SiTrkSimHitExtended*
6. Digitizer: class *SiTrkDetUnitDigitizer*
  - Primary ionization
  - Lorenz drift and diffusion
  - Induced pixel signals
7. Noises in DetUnit
8. Inefficiencies in DetUnit
9. Class *SiTrkClusteringProcessor*
10. Clusterizer: class *SiTrkDetUnitClustering*
11. Performance: first estimations
12. Plan

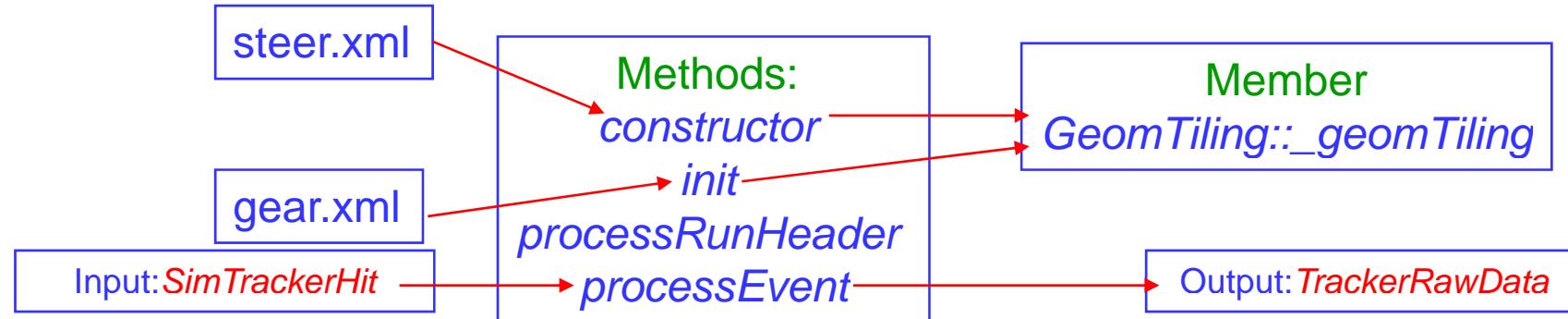
# What we had till now

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- *FTDDigiProcessor* and *VXDDigiProcessor* use simple Gaussian smearing to produce reconstructed *TrackerHit* from *SimTrackerHit* (**S.Aplin**)
- **VTXDigitizer (A.Raspereza)**: Input is *SimTrackerHit* and output is *TrackerHit*; physics in silicon is included (used CMS algoroitms), pixel mode
- **SiTrkDigiProcessor** and **SiTrkHitProcessor (S.Shulga)**:  
*SiTrkDigiProcessor* transforms *SimTrackerHit* collection to *TrackerRawData*.  
*SiTrkHitProcessor* transforms *TrackerRawData* to *TrackerHit*;  
only geometrical digitization and hit reconstruction,  
pixel and strip mode for barrel and FTD disks

The report describes new digitization and clustering processors  
within the framework of MarlinReco  
with use of algorithms developed in CMS (ORCA, COBRA).

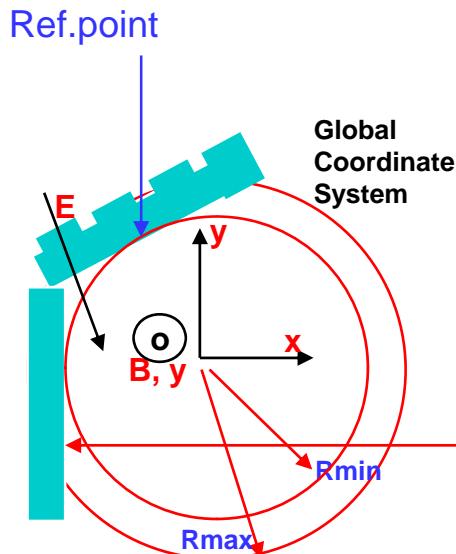
# Class SiTrkDigiProcessor



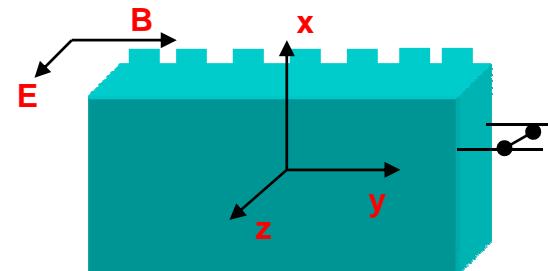
{Rmin,Rmax,Zmin,Zmax,NLadders}  
– complete information to define  
det.units for barrel

The objects to be digitized is “Detector Unit”.

*GeomTiling* prepares vector of vectors of *DetUnit*'s:  
first vector is over layer second vector is over *DetUnit* in layer.



*DetUnit* is rectangular thin parallelepiped in local coordinate system.



DU contain information about  
pixel XY-sizes and  
thickness

*BarrelDetUnit*, *ForwardDetUnit* are derived classes completely  
defined by type of DU (barrel or forward disk) and  
2-dimensional reference point in global coordinate system.

# Class *GeomTiling*

## Main members

- `vector< vector< DetUnit * > > _detUnitVecVec`
- `SiPixelDetUnitDigitizer _pdigitizer`
- `SiPixelDetUnitClusterizer _pclusterizer`
- `SiStripDetUnitDigitizer _sdigitizer` to be done
- `SiStripDetUnitClusterizer _sclusterizer` to be done

## Main methods

- `gearInit`
- `gearInitVXD` (called by `gearInit`)
- `gearInitFTD, gearInitSIT` to be done
- `fillDetUnits( SimTrackerHit * );`
- `digitizeDetUnits( vector<LCCollectionVec *> & )`
- `fillDetUnits( TrackerRawData * )`
- `clusterizeDetUnits( vector<LCCollectionVec *> & )`
- `clearDetUnits()`
- `howManySimHits()`
- `howManyRawHits()`

# Abstract base class *DetUnit*

## Main members

- *Hep3Vector \_BFieldLocal ;*
- *vector< SiTrkSimHitExtended \*> \_simHits ;*
- *SiTrkSimHitExtended \_simHit\_tmp ;*
- *Hep3Vector \_theDriftDirection ;*
- *map<int channel, class Amplitude> \_signal ;*
- *vector< IMPL::TrackerRawDataImpl \*> \_rawHits ;*
- *int \_electronPerADC;*
- *GaussianTileNoiseGenerator \_theNoiser ; // From ORCA*
- *double \_noiseInElectrons, // Noise (RMS)  
\_noiseInAdcCounts,  
\_pixelThresholdInNoiseUnits,  
\_pixelThresholdInElectrons,  
\_seedThresholdInNoiseUnits,  
\_clusterThresholdInNoiseUnits;*
- *vector<double> \_thePixelEfficiency,  
\_thePixelColEfficiency,  
\_thePixelChipEfficiency ;*
- *int \_rocSizeInX, //in pixels, nb of row's pixels per ROC  
\_rocSizeInY ; // --//-- column's pixels per ROC*

## Main methods

- *hitEntryExit(LCIO::IMPL::SimTrackerHit \* hit)*
- *setNLayer()*
- *setDetUnitNumber()*
- *double coordX( unsigned int row )*
- *double coordY(unsigned int column )*
- *unsigned int NpixelX( double X )*
- *unsigned int NpixelY( double Y )*
- *vector< SiTrkSimHitExtended \*> getSimHits()*
- *vector< IMPL::TrackerRawDataImpl\*> getRawHits()*
- *Hep3Vector driftDirection()*
- *void addSignalFromSimHit( map<int,double> hit\_signal),  
SiTrkSimHitExtended \* hit)*
- *void add\_noise()*
- *void pixel\_inefficiency()*
- *void make\_digis( LCCollectionVec \*rawVec,  
LCCollectionVec \*relVec)*

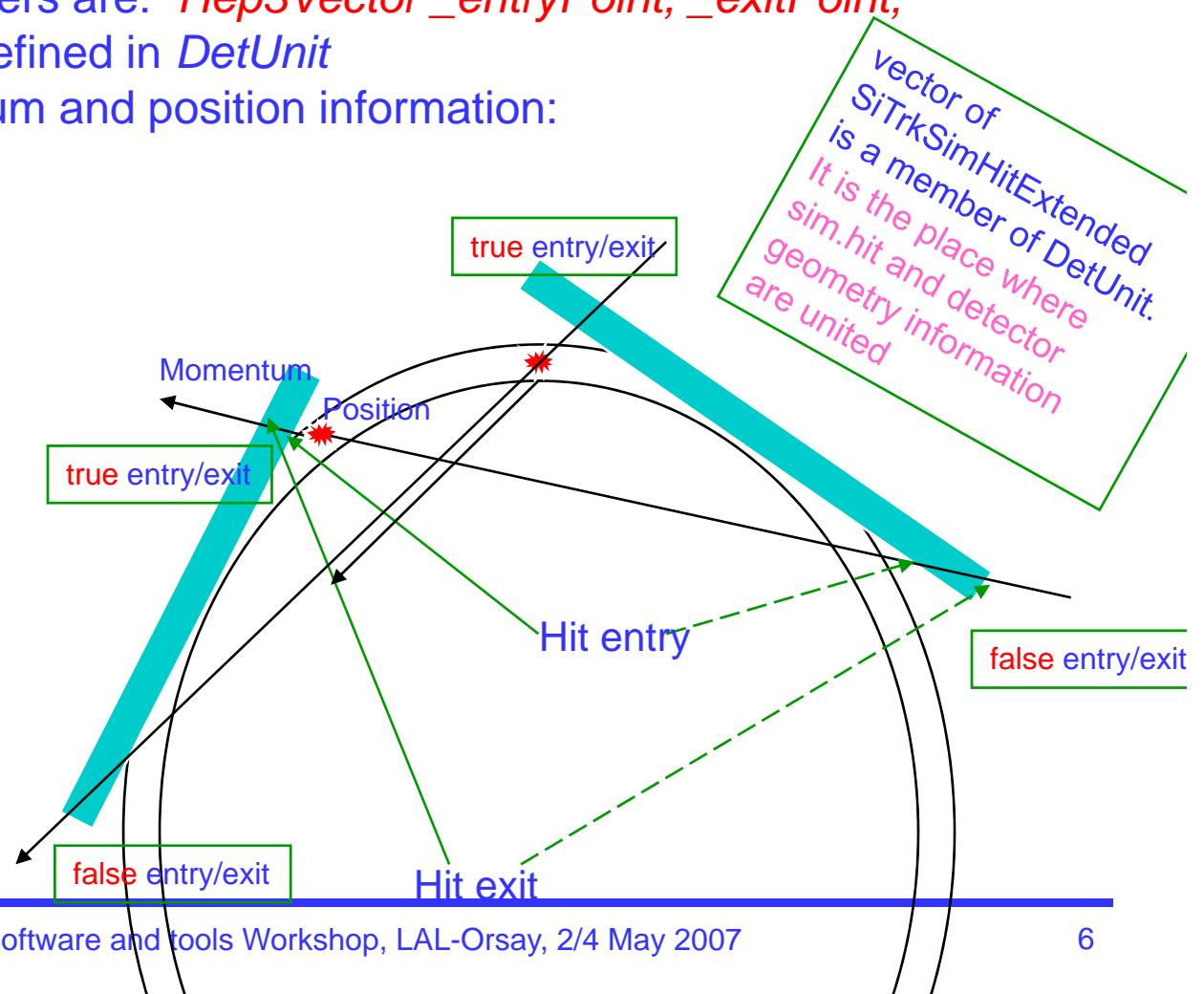
# Why we need class *SiTrkSimHitExtended* ?

*SiTrkSimHitExtended* is derived class from LCIO class *IMPL::SimTrackerHit*.

The main additional members are: *Hep3Vector \_entryPoint, \_exitPoint;*  
Entry and exit points are defined in *DetUnit*  
by *SimTrackerHit* momentum and position information:

Solution of the ambiguity shown:  
nearest entry-exit are true.  
It require two loops  
over the det.units in *GeomTiling*  
for given layer  
at stage of *fillDetUnits( SimHit )*.

**Flexibility:**  
It allow us to use  
simple Mokka model  
for different structure  
of layers and det.units



## *SiTrkDetUnitDigitizer::digitize( DetUnit )* (adapted from ORCA)

### Primary ionization

```
NSegments = mag(exit - entry)/segment_length ;
```

```
vector< EnergyDepositUnit > _ionization_points ;
```

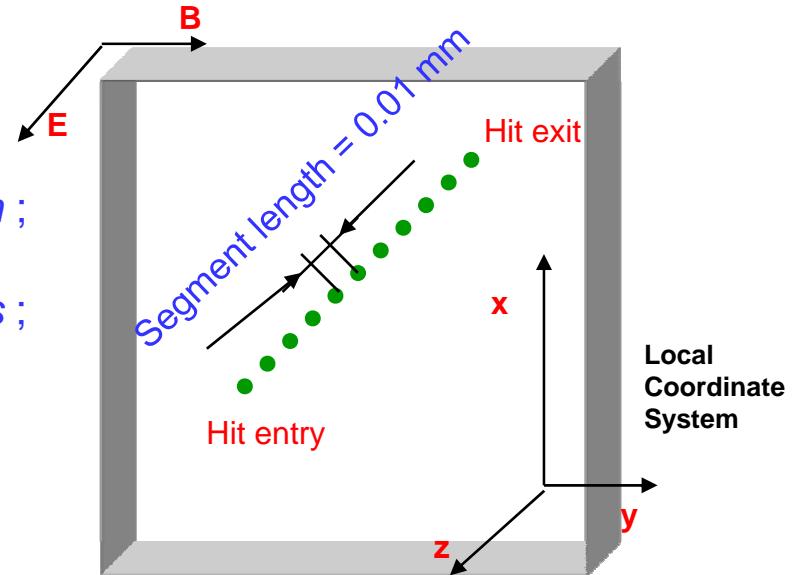
```
_ionization_points.resize( NSegments ) ;
```

Members of *EnergyDepositUnit*  
are *EnergyLoss* in electrons  
and *Position* in local coord.system:

```
EnergyLoss = EnergyLossGEV[i]/_GevPerElectron ;
```

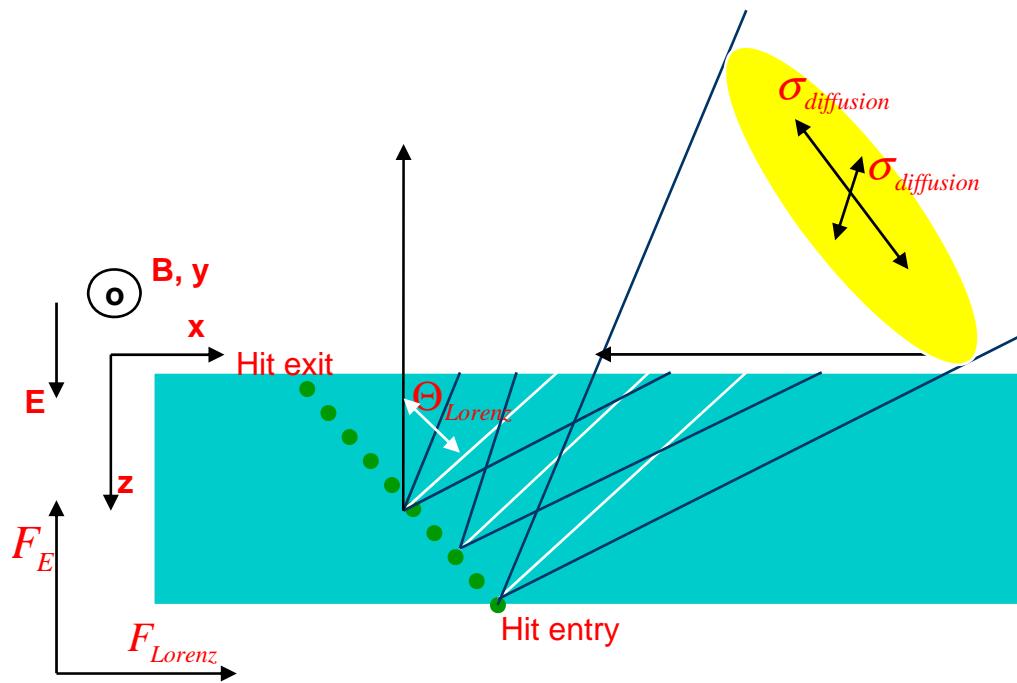
```
_GevPerElectron = 3.7 E-9 ; // 1 electron = 3.7 eV
```

*EnergyLossGEV[i]* is defined by function  
of Landau fluctuation in thin silicon layer  
(GEANT4 function *MyG4UniversalFluctuationForSi*).

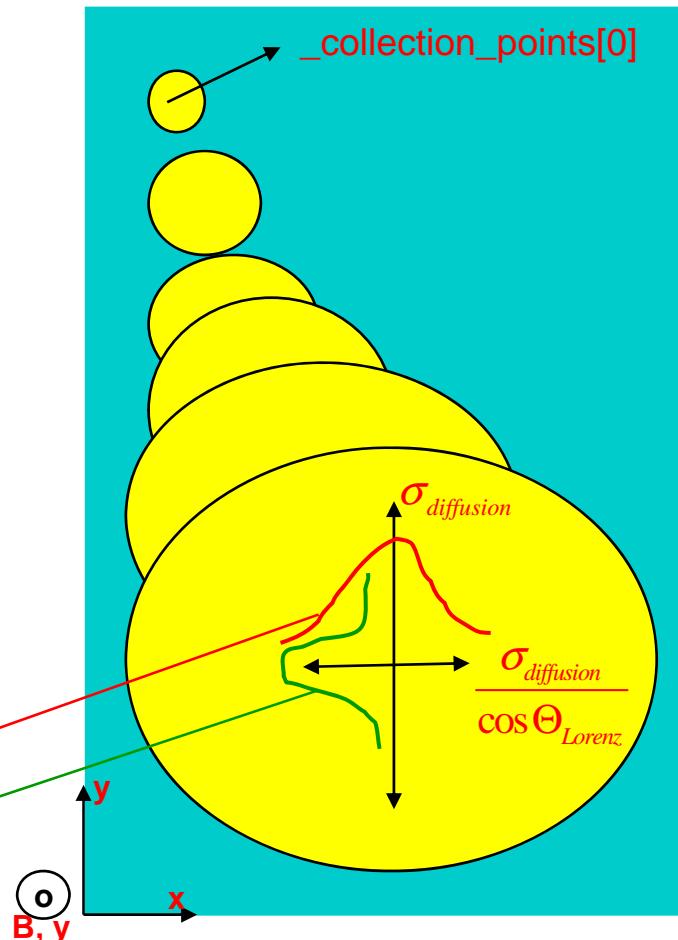


## *SiTrkDetUnitDigitizer::digitize( DetUnit )*

### Lorenz drift and diffusion

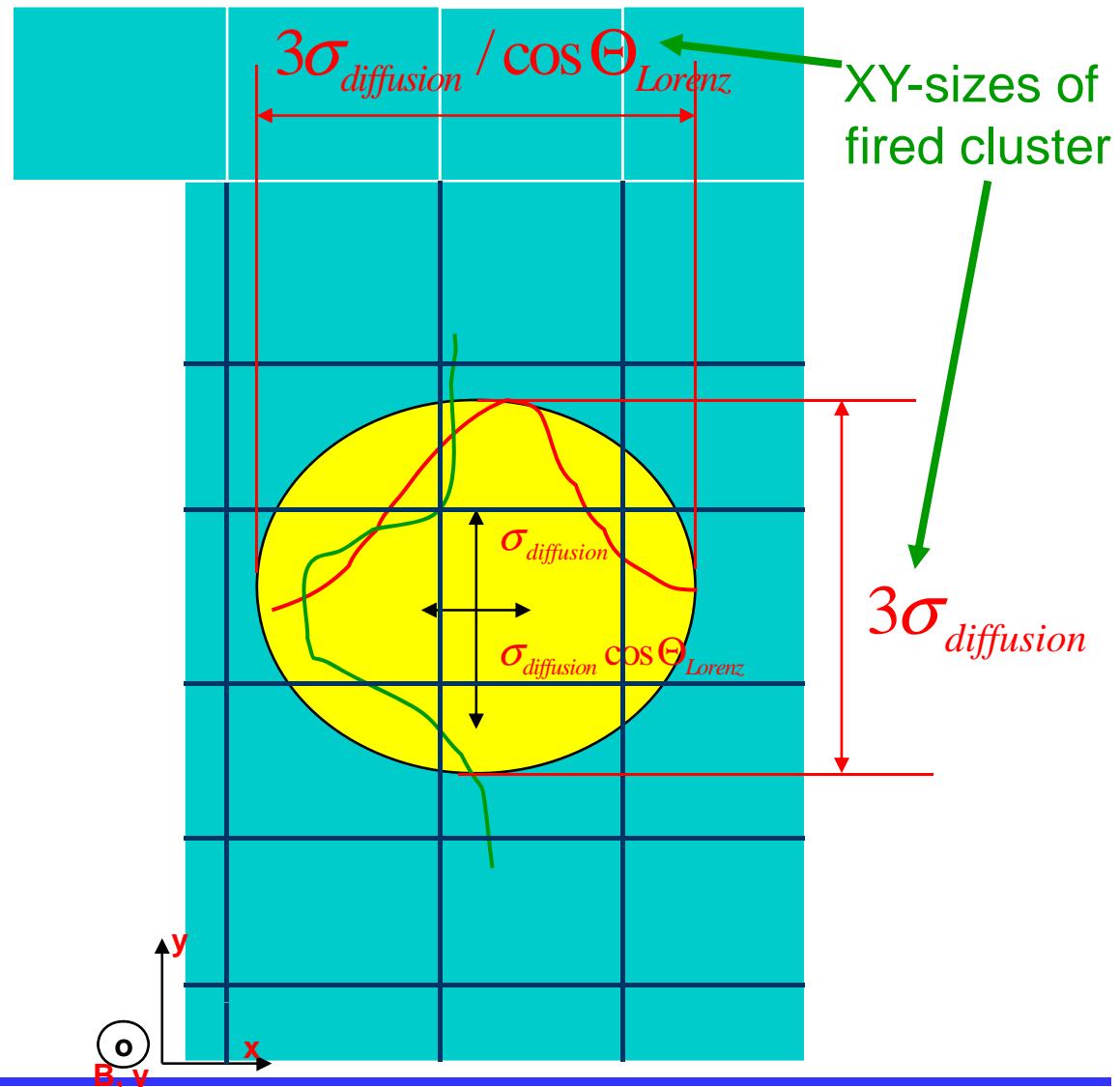


At the picture 6 points are shown :  
 $_collection\_points[6]$  from 6  $_ionization\_points[6]$



## *SiTrkDetUnitDigitizer::digitize( DetUnit )*

Induced signal



## *SiTrkDetUnitDigitizer::digitize( DetUnit )*

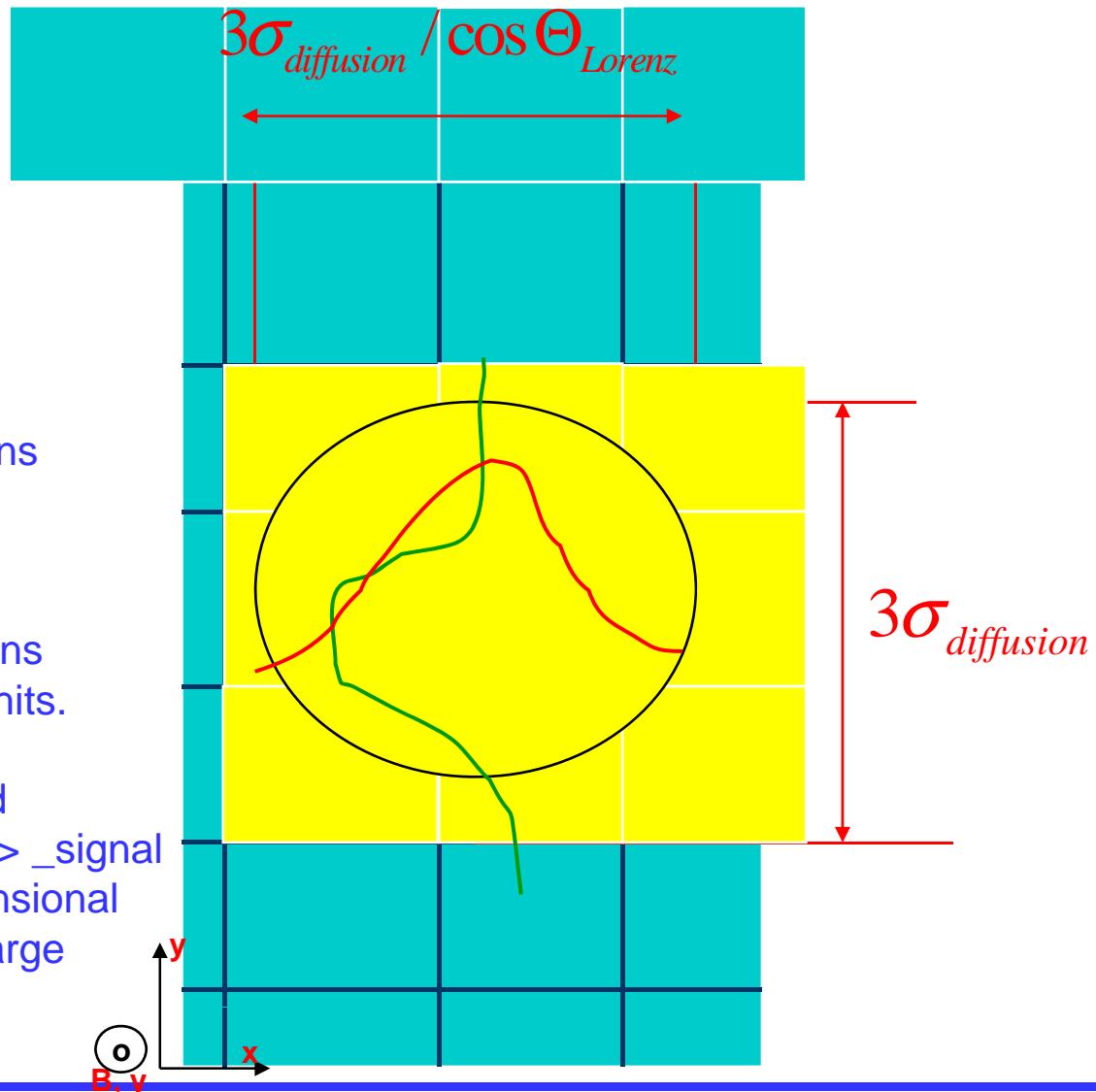
### Induced signal

In each fired (yellow) pixel 2-dimensional integral is calculated according to gaussian distribution of charge for each *\_collection\_point[i]*.

For given pixel charge fractions are summarized over the *\_collection\_point[i]*.

For all sim.hits charge fractions are summarized over the sim.hits.

All fired pixels are collected in *map< int channel, double charge> \_signal* where *channel* is packed 2-dimensional pixel number, *charge* is full charge from all sim.hits in event.



## *DetUnit::add\_noise()* (adapted from ORCA)

**First** calculate noise in each hit pixels around zero by  
`noise = CLHEP::RandGaus::shoot( 0., _noiseInElectron )`  
and add them to hit pixel (noise can be negative).

`_noiseInElectron == RMS of gaussian distribution (== 500.)`

**Secondly**, calculate noise in non-hit pixels (noisy channels)  
by `GaussianTileNoiseGenerator _theNoiser ;`

Mean number of noise pixels  
`Nmean = R * Npixels`

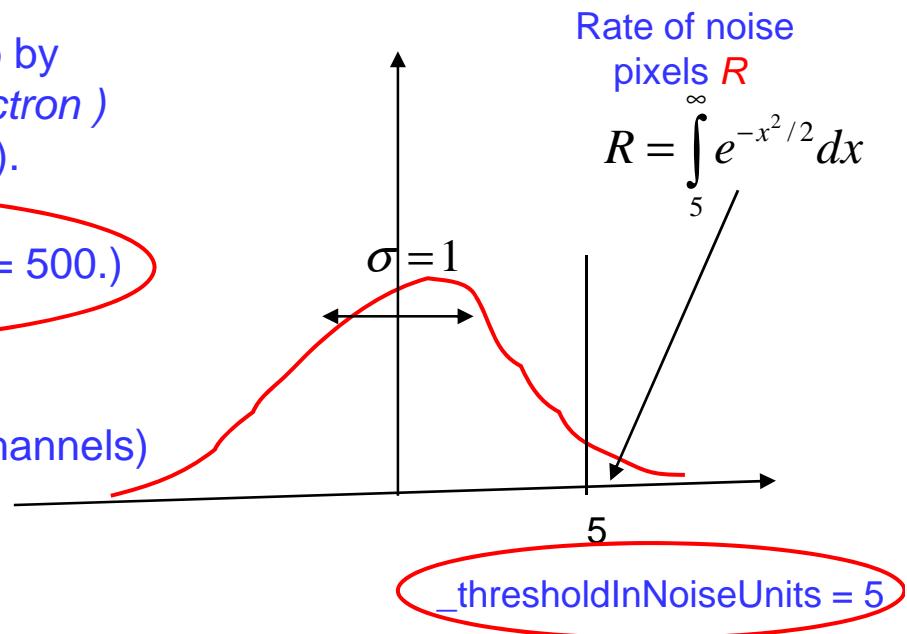
Number of noise pixels `Npix = CLHEP::RandPoisson::shoot( Nmean )`

Next step is to calculate *Npix channel numbers*  
= flat random number in [0, Npix].

It will be the numbers of noisy channel (pixel).

In each noisy channel

`noise = random value of Gaus.distr.(mean=0, sigma= 500.)`  
in interval  $[5*500, \infty]$



**Two noise parameters:**  
`_noiseInElectrons`  
and  
`_thresholdInNoiseUnits`

## *DetUnit::pixel\_inefficiency()*

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Inefficiency parameters :

`_pixelEfficiency = 99%,` for single pixel

`_pixelDoubleColumnEfficiency = 99%,` for double column of pixels

`_pixelReadOutChipEfficiency = 99.75%` for readout chip

To calculate ROC inefficiency two parameters are used:

`_rocSizeInX` and `_rocSizeInY` (in units of pixel sizes)

## List of default parameters of *SiTrkDigiProcessor*

**Ionization segment length = 0.01 mm**

**Lorenz drift and diffusion :**

$$\tan \Theta_{Lorenz} = 0.106 * B, B = 4Tesla$$

$$\sigma_{diffusion} / (0.300mm) = 0.007$$

**fired cluster width = [3\* $\sigma_x$ ,3\* $\sigma_y$ ],  $\sigma_x, \sigma_y = f(\Theta_{Lorenz}, \sigma_{diffusion})$**

**Noise parameters :**

`_noiseInElectrons = 500.,`

`_thresholdInNoiseUnits = 5 ;`

**Inefficiency parameters :**

`_pixelEfficiency = 99%,`

`_pixelDoubleColumnEfficiency = 99%,`

`_pixelReadOutChipEfficiency = 99.75%`

`_rocSizeInX = 20 pixels`

`_rocSizeInY = 52 pixels`

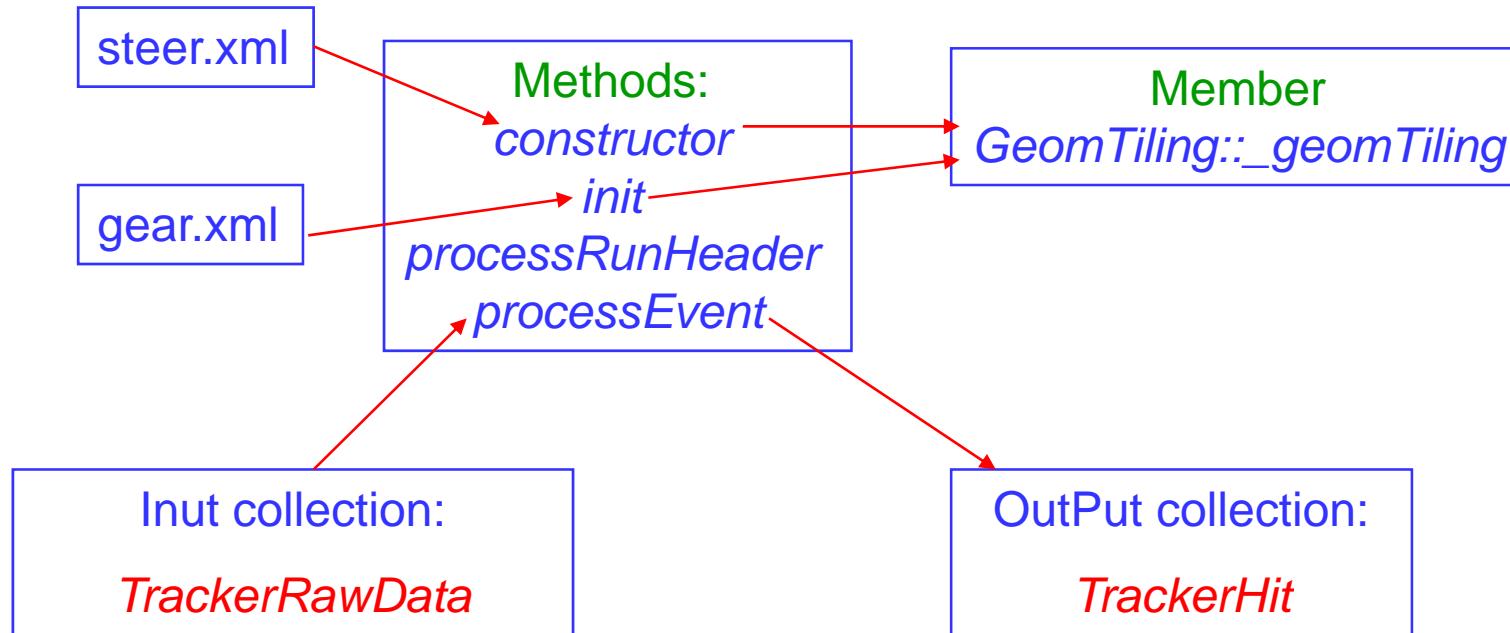
**Pixel sizes**

`_pixSizeX = 0.100 mm`

`_pixSizeY = 0.150 mm`

## Clustering: class *SiTrkClusteringProcessor*

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# Class *GeomTiling*

## Main members

- `vector< vector< DetUnit * > > _detUnitVecVec`
- `SiPixelDetUnitDigitizer _pdigitizer`
- `SiPixelDetUnitClusterizer _pclusterizer`
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## Main methods

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- `fillDetUnits( TrackerRawData * )`
- `clusterizeDetUnits( vector<LCCollectionVec *> & )`
- `clearDetUnits()`
- `howManySimHits()`
- `howManyRawHits()`

# Abstract base class *DetUnit*

## Main members

- `_rawHits;`
- `_seedThresholdInNoiseUnits,`
- `_clusterThresholdInNoiseUnits;`
- `vector< IMPL::TrackerRawDataImpl * > _rawHits ;`
- `vector< IMPL::TrackerRawDataImpl* > getRawHits()`
- `the threshold of channel charge to start clusterizing around seeded clusters (DEFAULT = 6)`
- `the threshold of cluster charge to kill Some found clusters (DEFAULT = 10.1)`

No any special methods  
for clustering  
In DetUnit class

## *class SiTrkDetUnitClustering*

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The clusterization is performed on a matrix with size equal to the size of the pixel detector.

Each cell contains the ADC count of the corresponding pixel.

The search starts from seed pixels, i.e. pixels with sufficiently large amplitudes.

Clusters are set of neighbour pixels including pixels which touched by corners.

ORCA/COBRA set of classes are used.

**Performance:** Mokka06-01, model “vxd\_00”,  
 MC events: Pythia6.410, MSEL=6,  $e^+e^- \rightarrow tt \rightarrow X$ , c.m.s. energy=500 GeV

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Preliminary

Event number	1	2	3	4	5	
Nb of charged MC particles	32	36	50	18	44	
Nb of MC part. X 5 Layers	160	180	250	120	220	
Sim.hits in VXD :	227	198	336	69	397	
Nb of sim.hits with $p>1\text{GeV}$ :	105	125	170	41	124	
Raw hits in VXD:	595	428	780	164	761	pixels 50x75
Clusters in VXD:	138	103	169	37	211	
Noises = 0, inefficiencies = 0						
Raw hits in VXD:	544	374	725	150	684	pixels 50x75
Clusters in VXD:	137	105	178	39	202	
Raw hits in VXD:	290	168	326	81	77	pixels 70x100
Clusters in VXD:	69	31	69	15	62	
Raw hits in VXD:	101	43	102	32	73	pixels 100x150
Clusters in VXD:	17	4	29	4	8	

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# Plan

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- Pixel mode for FTD layers
- Strip digitizer for FTD and SIT
- Clustering and hit reconstruction for strip detectors
- Performance study together with track finding processors

Digitization and clustering processors described above  
will be placed in official *MarlinReco CVS* directory  
till LCWS07